Application/Control No. Applicant(s)/Patent Under Reexamination 10/613,497 CHEN, TIENTEH Notice of References Cited Examiner Art Unit Page 1 of 1 1774 Betelhem Shewareged **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,777,039 08-2004 Koike et al. 428/32.26 Α US-В US-С US-D US-Ε F US-G USн US-US-US-US-K US-L М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

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